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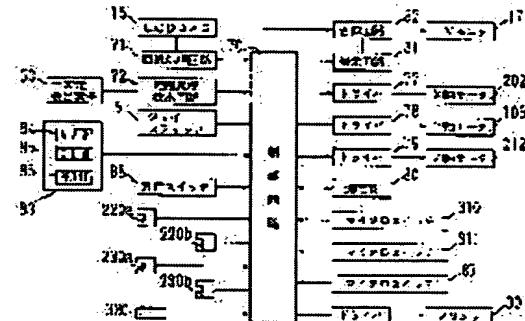
(21)Application number : 08-334591 (71)Applicant : NIDEK CO LTD
(22)Date of filing : 29.11.1996 (72)Inventor : MIWA TETSUYUKI

(54) OPHTHALMOLOGIC APPARATUS

(57) Abstract:

PROBLEM TO BE SOLVED: To achieve safe protection of a person to be inspected with the reduction in his anxiety by forbidding the operation of a return means in all or specified directions thereof when a danger of contact between the eyes to be inspected and the apparatus is detected as associated with the operation of the return means to avoid undesired access of the apparatus to a face of the person to be inspected.

SOLUTION: A return command signal is emitted to return a measuring part to each reference position in directions X and Z when a clear switch 85 or a print switch 86 is depressed, when the rear end of the body part is detected by a microswitch or when the switching of right and left eyes is detected by a microswitch 310. Upon the emitting of the return command signal, a control circuit 70 judges whether the eyes to be inspected exist near a nozzle part or not from alignment information of an index image formed by an index projection optical system and when the existence of the eyes to be inspected near the nozzle is determined, the return command signal emitted is not accepted and the returning movement of the measuring part to the reference position is forbidden.



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